

MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

60 V, 87 A, 4.3 m Ω

FDMC86570LET60

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

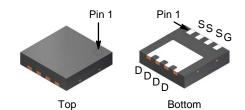
Features

- Extended T_I Rating to 175°C
- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 4.3 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 18 \text{ A}$
- Max $r_{DS(on)} = 6.5 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 15 \text{ A}$
- High Performance Technology for Extremely Low r_{DS(on)}
- Termination is Lead-free
- RoHS Compliant

Applications

• DC-DC Conversion

V _{DS}	r _{DS(on)} MAX	I _D MAX
60 V	4.3 mΩ @ 10 V	87 A
	6.5 mΩ @ 4.5 V	



WDFN8 3.3x3.3, 0.65P (Power 33) CASE 483 AW

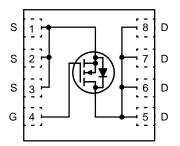
MARKING DIAGRAM

ZXYYKK FDMC 86570LT

Z = Assembly Plant Code
XYY = 3-Digit Date Code Format
KK = 2-Alphanumeric Lot Run
Traceability Code

FDMC86570LT = Device Code

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

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MOSFET MAXIMUM RATINGS ($T_A = 25$ °C unless otherwise noted)

Symbol	Parameter				Unit
V _{DS}	Drain to Source Voltage			60	V
V _{GS}	Gate to Source Voltage			±20	V
I _D	Drain Current – Continuous	T _C = 25°C	(Note 5)	87	Α
	- Continuous	T _C = 100°C	(Note 5)	62	
	- Continuous	T _A = 25°C	(Note 1a)	18	Α
	- Pulsed		(Note 4)	436	Α
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	253	mJ
P_{D}	Power Dissipation	T _C = 25°C		65	W
	Power Dissipation	T _A = 25°C	(Note 1a)	2.8	1
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
R _θ JC	Thermal Resistance, Junction to Case (Note 1)	2.3	°C/W
RθJA	Thermal Resistance, Junction to Ambient (Note 1a)	53	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

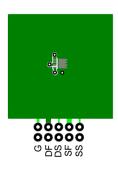
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	60	_	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	30	_	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V	-	_	1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	±100	nA
ON CHARAC	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	-7	-	mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 18 A	-	3.1	4.3	mΩ
		V _{GS} = 4.5 V, I _D = 15 A	_	4.7	6.5	
		V _{GS} = 10 V, I _D = 18 A, T _J = 125°C	-	5.0	6.9	
9FS	Forward Transconductance	V _{DD} = 5 V, I _D = 18 A	-	75	_	S
DYNAMIC C	HARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz	-	4790	_	pF
C _{oss}	Output Capacitance		_	821	_	pF
C _{rss}	Reverse Transfer Capacitance		-	19	_	pF
R _g	Gate Resistance		0.1	0.9	2.7	Ω
SWITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, I_D = 18 \text{ A}, V_{GS} = 10 \text{ V},$	-	19	34	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$	-	6.2	12	ns
t _{d(off)}	Turn-Off Delay Time	1	-	38	61	ns
t _f	Fall Time		_	3.9	10	ns

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted) (continued)

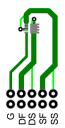
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
WITCHING	CHARACTERISTICS					
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V, V _{DD} = 30 V, I _D = 18 A	_	63	88	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}, V_{DD} = 30 \text{ V}, I_D = 18 \text{ A}$	-	29	41	nC
Q _{gs}	Gate to Source Charge	V _{DD} = 30 V, I _D = 18 A	-	14	_	nC
Q _{gd}	Gate to Drain "Miller" Charge		_	6.3	_	nC
RAIN-SOL	JRCE DIODE CHARACTERISTICS					
3D	Source to Drain Diode Forward	V _{GS} = 0 V, I _S = 18 A (Note 2)	_	0.8	1.3	V
	Voltage	V _{GS} = 0 V, I _S = 1.9 A (Note 2)	-	0.7	1.2	
t _{rr}	Reverse Recovery Time	I _F = 18 A, di/dt = 100 A/μs	-	43	69	ns
Q _{rr}	Reverse Recovery Charge		_	26	42	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{1.} $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR–4 material. $R_{\theta CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. E_{AS} of 253 mJ is based on starting $T_J = 25^{\circ}$ C, L = 3 mH, $I_{AS} = 13$ A, $V_{DD} = 60$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 43$ A. 4. Pulsed Id please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

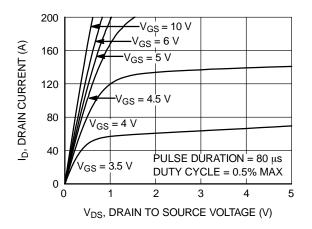


Figure 1. On-Region Characteristics

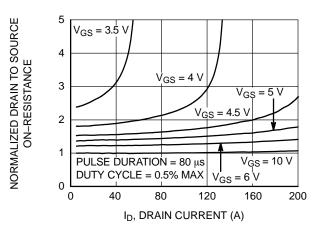


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

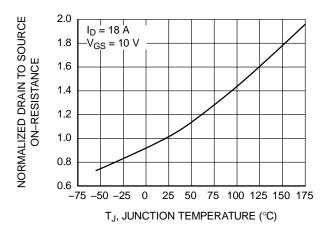


Figure 3. Normalized On–Resistance vs. Junction Temperature

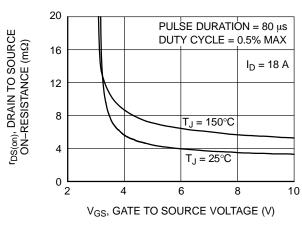


Figure 4. On-Resistance vs. Gate to Source Voltage

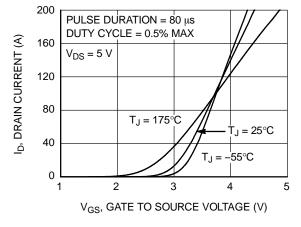


Figure 5. Transfer Characteristics

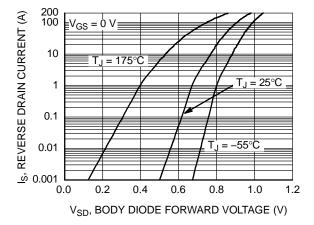


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

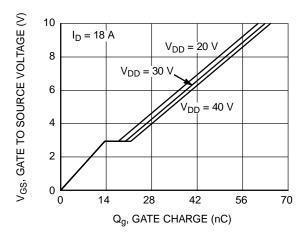


Figure 7. Gate Charge Characteristics

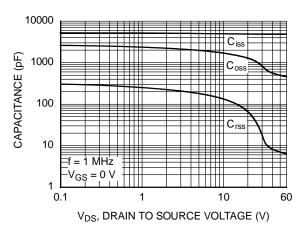


Figure 8. Capacitance vs. Drain to Source Voltage

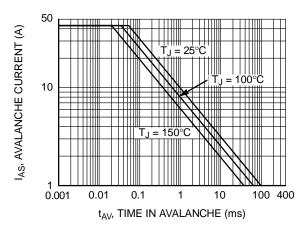


Figure 9. Unclamped Inductive Switching Capability

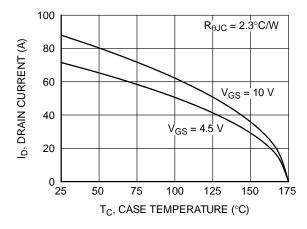


Figure 10. Maximum Continuous Drain Current vs.

Case Temperature

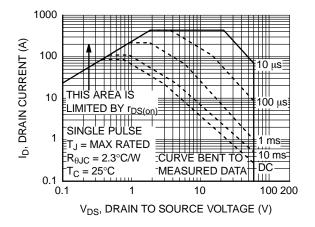


Figure 11. Forward Bias Safe Operating Area

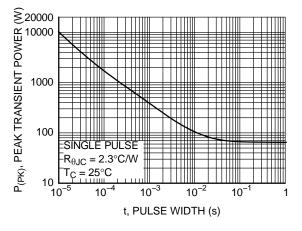


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

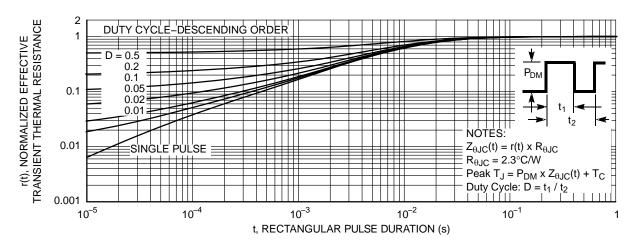


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMC86570LET60	FDMC86570LT	WDFN8 3.3x3.3, 0.65P Power 33	13"	12 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





TERMINAL #1

INDEX AREA

(D/2 X E/2)

⊃ aaa C

WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

DATE 22 MAR 2024

NOTES:

С

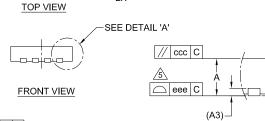
SEATING

PLANE

<u></u>

DETAIL A

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- ©COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



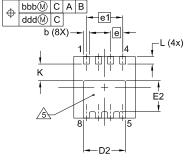
2X

aaa C

Α

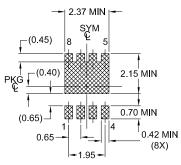
5

В



BOTTOM VIEW

LAND PATTERN RECOMMENDATION



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

MILLIMETERS DIM MIN NOM MAX 0.70 0.75 Α 0.80 Α1 0.05 А3 0.20 REF b 0.27 0.32 0.37 D 3.30 BSC D2 2.17 2.27 2.37 Ε 3.30 BSC E2 1.56 1.66 1.76 е 0.65 BSC 1.95 BSC e1 Κ 0.90 L 0.30 0.40 0.50 0.10 aaa bbb 0.10 0.10 CCC ddd 0.05 0.05 eee

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON13672G	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	WDFN8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1		

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